

Notice of References Cited	Application/Control No. <i>09/878,556</i>	Applicant(s)/Patent Under Reexam <i>Iyer et al.</i>	
	Examiner <i>Tark Chen</i>	Art Unit <i>2813</i>	Page <i>1</i> of <i>1</i>

Applicant(s)/Patent Under Reexam

Iyer et al.

Art Unit	
----------	--

2813

Page 1 of 1

U.S. PATENT DOCUMENTS					
* #	Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
A	6,091,109 ✓	7/2000	Hasegawa	257	339
B	6,143,669 ✓	11/2000	Cho	438	770
C	6,300,197 B1	10/2001	Inaba	438	258
D	6,335,262 B1 ✓	1/2002	Crowder et al.	438	440
E					
F					
G					
H					
I					
J					
K					
L					
M					

FOREIGN PATENT DOCUMENTS						
* #	Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Country	Name	Classification ²	
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS	
*	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	
V	
W	
X	

¹ Dates in MM-YYYY format are publication dates.

² Classifications may be U.S. or foreign.